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# Towards industrialization of perovskite solar cells using slot die coating

Anand Verma,<sup>a</sup> David Martineau,<sup>b</sup> Erwin Hack,<sup>c</sup> Mohammed Makha,<sup>a, d</sup> Erik Turner,<sup>e</sup> Frank Nüesch<sup>a, f</sup> and Jakob Heier<sup>a, \*</sup>

<sup>a</sup> Laboratory for Functional Polymers, Empa, Swiss Federal Laboratories for Materials Science and Technology, Überlandstrasse 129, CH-8600 Dübendorf, Switzerland.

<sup>b</sup> Solaronix, S.A., Rue de l'Ouriette 129, CH-1170 Aubonne, Switzerland.

<sup>c</sup> Transport at Nanoscale Interfaces, Empa, Swiss Federal Laboratories for Materials Science and Technology, Überlandstrasse 129, CH-8600 Dübendorf, Switzerland.

<sup>d</sup> Current address: Materials Science and Nano-engineering Department, Mohammed VI Polytechnic University (UM6P), Lot 660, Hay Moulay Rachid, 43150 Bengurir, Morocco.

<sup>e</sup> Haldenstrasse 27, CH-8955 Oetwil an der Limmat, Switzerland.

finstitut des Matériaux, École Polytechnique Fédérale de Lausanne, EPFL Station 12, CH-1015 Lausanne, Switzerland.

Corresponding author: Jakob.Heier@empa.ch

 $\dagger$  Electronic supplementary information (ESI) available: Video of layer coating by slot die coating, efficiency measurements, cell geometry and surface tension measurement including Figure S1 – S6 and Table S1 – S2.

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The carbon-based hole transport layer-free carbon mesoscopic perovskite solar cell (MPSCs) is considered as cell architecture with high potential for commercialization, due to its enhanced stability. In the standard process for large area and module fabrication, mesoporous layers of TiO<sub>2</sub>, ZrO<sub>2</sub> and carbon are screen printed onto fluorine doped tin oxide (FTO) coated with a compact TiO<sub>2</sub> (cTiO<sub>2</sub>) layer. In this work, we sequentially replaced screen printing by slot die coating one by one for all layers until we achieved a fully slot die coated solar cell. Slot die coating is a manufacturing technique with a much higher throughput than screen printing. We demonstrate that slot die coated layers do not need to be sintered separately as opposed to the screen printed layers, but can rather be co-fired for increased manufacturing speed and efficacy. We characterize inks, the coating process, the morphology and performance of these solar cells. The cells show efficiencies comparable to the ones of the screen printed control devices. The cells also show an extraordinary high shelf life stability. We also demonstrate that ellipsometry can be used as an efficient (in-situ) tool to characterize the stack structure of the cells.

## Introduction

Rapid improvement in efficiency of Perovskite solar cells (PSC) in just a few years triggered tremendous research and development efforts in this photovoltaic technology domain.<sup>1-9</sup> Presently most of the research is focused on exploring materials and device architectures leading to efficiency milestones and device stability. The record perovskite power conversion efficiency to date (NREL efficiency chart from February 18, 2020) lies at 25.2 % with a so-called planar structure.<sup>1</sup>

The success of commercializing perovskite solar cells relies on key advantages to compete with established photovoltaic technologies. For example, PSCs can be processed from solution, resulting in low production cost and smaller capital expenditure. Historically, perovskites were first used as dye substitutes in dye sensitized solar cells (DSSC), whereby the perovskite crystals grew in the mesoporous scaffold. Based on this device architecture, the carbon-based hole transport layer-free mesoscopic perovskite solar cell (MPSC) was developed. While this cell architecture cannot compete with planar structures in terms of efficiency, excellent device stability was demonstrated for fully screen printed devices. <sup>10-13</sup> For this device geometry, highest efficiencies have been achieved with a mesoporous metal oxide TiO<sub>2</sub>/Al<sub>2</sub>O<sub>3</sub>/NiO layered framework with a carbon counter electrode and the triple cation perovskite Cs<sub>0.05</sub>(FA<sub>0.4</sub>MA<sub>0.6</sub>)<sub>0.95</sub>Pbl<sub>0.8</sub>Br<sub>0.2</sub>. Devices were tested on an area of 0.129 cm<sup>2</sup> and showed a record efficiency of 17.02 %.<sup>14</sup>

The most followed route for up-scaling MPSCs is via screen printing, sometimes including a spray coating process for the cTiO<sub>2</sub> layer.<sup>12, 15</sup> The infiltration of methyl ammonium lead iodide (MAPbI<sub>3</sub>) ink

has been demonstrated using inkjet printing and using slot die coating by Hashmi et al. and Cotella et al., respectively. 12, 16 Due to difficulties in controlling large area film formation, perovskite crystallization and high-quality interfaces, the maximum efficiencies drop dramatically with increasing device area, posing huge challenges to the research community. On the solar module level, poor module design is causing an efficiency drop at larger dimensions. 17, 18

Fully screen printed MPSCs have been manufactured by NTU Singapore, employing manual infiltration of the perovskite precursor ink (efficiencies of their cells reached maximum values of 10.74 % on an active area of 70 cm<sup>2</sup>), <sup>15</sup> and Swansea University with screen printed modules showing efficiencies of 6.6%. <sup>19</sup> Apart from research institutions, a number of start-up companies, but also well-established electronic companies work on the development of perovskite solar cell modules. <sup>20</sup> Attempts to scale-up other perovskite device architectures range from ink jet printing to slot die coating of individual layers. <sup>12, 15, 21, 22</sup>

Not reported in the literature though is a holistic solution for PSC cell manufacturing, with the requirement to build the complete perovskite solar cell at industrially relevant speeds, preferentially with one and the same technique. While screen printing is comparatively fast and scalable, in terms of processing speed it cannot compete with printing and coating techniques such as gravure printing, flexo printing or slot die coating.<sup>23</sup>

Nevertheless, slot die coating has not surfaced in the literature as a promising coating technique for MPSCs. But, if successfully implemented, all the issues mentioned above can be addressed. Slot die coating is fully compatible with industry standards.<sup>24</sup> With coating speeds ranging from less than 1 mm/min to more than 600 m/min, it has been very successfully used to manufacture organic solar cells <sup>25</sup> and has been used to apply single perovskite layers.<sup>26</sup>

Slot die coating is a non-contact large area processing method for the deposition of homogeneous, defect-free wet films with high cross-directional uniformity.<sup>27</sup> Slot die coating is a pre-metered technique, with the major benefit that the wet film thickness can be preset and precisely calculated from the flow rate of the fluid and the coating speed. Finally, slot die coating is roll-to-roll compatible and stripe module design friendly. This makes slot die coating an a priori useful tool for printed electronics applications.<sup>28</sup>

Slot die coating covers inks within a wide viscosity window ranging from 1 mPas to 10,000 mPas <sup>29</sup> and final dry thicknesses from a few nanometers to tens of microns can be reached. Of major concern though is the determination of the operation limits which are needed to set the parameters of coating speed, flow rate and coating gap. Even though a couple of theories describe the operation limits,<sup>30</sup> the mechanism behind coating instabilities is poorly understood. A number of competing forces act on the coating bead, such as capillary, viscous, inertial and elastic forces.<sup>31, 32</sup> An operation near the operation limits can trigger coating defects.<sup>24, 33</sup>

We here apply the visco-capillary model that only considers the fluid meniscus at the downstream lip of the slot die and is valid when air entrainment is not occurring (Fig. 1). Useful in this context is the introduction of the capillary number Ca, which expresses the coating speed v in a dimensionless form including viscosity  $\eta$  and surface tension  $\sigma$  of the liquid:

$$Ca = \frac{\eta v}{\sigma} \tag{1}$$

Above a critical pressure in the coating bead, the film thickness is too low to form a stable wet film. This is the so-called low flow limit. Ruschak developed a theoretical model that defined a critical capillary number above which the flow field of the coating bead between die and substrate becomes unstable:<sup>34</sup>

$$Ca_{crit} = n \left(\frac{2}{G-1}\right)^{\frac{3}{2}} \tag{2}$$

whereby G is the ratio of the height of the gap between substrate and lip  $h_G$  and the thickness of the wet film  $h_{wet}$ :

$$G = \frac{h_G}{h_{wet}} \tag{3}$$

Thus, increasing *G* will lead to unstable coating for larger capillary numbers.

In this paper we describe the complete fabrication process of MPSC modules with competitive efficiencies using only slot die coating. The inks for slot die coating are based on the pastes developed for screen printing. The different fluid dynamic requirements to the ink make composition adaption necessary, which will alter the final film properties, not to mention differences in wetting, drying and interface formation behavior. Manufacturing of all individual layers, and the influence of ink and solvents will be detailed below, and in the Electronic supplementary information (ESI†).

## **Results and Discussion**

Fig. 2a shows a schematic cross section of the monolithic perovskite solar cell structure. For module manufacturing, small stripes need to be serially connected, which can be realized by printing individual lines with an offset, or by scribing the lines P1, P2 and P3 in a large area coating. Slot die coating allows for large area coating, as well as for "module friendly" stripe coating. The second concept is implemented in our module fabrication process, but only for demonstration purposes. A diagram of the final manufacturing process is shown in Fig. 2b. To manufacture efficient modules, the line accuracy and width between the stripes would need to be further optimized. Consequently, we

here also do not report module efficiencies, but rather values for 0.64 cm<sup>2</sup> areas on samples cut from the slot die coated substrates (Fig. 2c).

In a first step, inks for all individual layers were developed for slot die coating and the process was optimized for the required layer thicknesses. Images of the inks, substrates coated with stripes of cTiO<sub>2</sub>, mTiO<sub>2</sub>, mZrO<sub>2</sub> and carbon, as well as two videos demonstrating large area coating by slot die coating are shown in Fig. S1 in the ESI†. In a second step, screen printed layers were replaced individually by slot die coated layers, starting from the bottom. Only when the devices reached an efficiency comparable to the reference cell, the next slot die coated layer was implemented. Generally, all individual layers were dried and sintered after deposition. A further highlight of this work is the finding that slot die coating allowed co-firing of the full solar cell stack before perovskite infiltration, presenting the possibility to continuously produce MPSCs with least down time possible. Differently, to reach best efficiencies, screen printed cells required sintering after each deposition step.

To fabricate the reference device, we followed a recipe based on a fully screen-printed stack.<sup>35</sup> The optimal thickness of the stack has been reported by many research groups.<sup>12, 15</sup>

## Ink formulation and layer coating

#### Compact TiO<sub>2</sub>

The compact titania layer acts as a blocking layer in the MPSC structure and thus requires a homogeneous conformal coating, free of defects and pinholes. A specific challenge is the roughness of the FTO substrate, as well as crack formation during drying or due to stress.

The titanium diisopropoxide bis(acetylacetate) precursor (TAA) was used as the basis for ink development.<sup>36</sup> In the following we exemplarily describe the strategies that led to the formation of a uniform cTiO<sub>2</sub> coating. Ink formulation and parameter settings of the slot die coater depend on each other and are matched in several iteration steps. In the first attempt, the TAA precursor ink was slot die coated as supplied onto a FTO glass substrate. Here, a stable meniscus formed between bead and substrate, which is a mandatory prerequisite for successful coating. In our case, even though a stable meniscus was formed, the wet and dry films were very inhomogeneous. Too fast drying of the wet film was identified as cause, the precursor solution was thus diluted with high boiling point (BP) solvents like ethylene glycol (BP: 196°C), tetralin (BP: 206°C), and xylene (BP: 144°C). In addition, to reach the desired thickness of 50 nm, a series of concentrations and flow rates were tested. While the first trials with all high boiling inks had yielded immediately a homogeneous wet film, upon drying, the film started to de-wet, showed bad pinning and uneven drying. The result of such a coating with a TiO<sub>2</sub> (Tetralin) (1:10) solution are shown in Fig. 3a. Applying the solution a second time

(wet on wet coating) improved substrate pinning (Fig. 3b). The strategy of solvent mixtures (high and low BP) was adopted to improve thin film formation and counter the de-wetting of the film. Isopropanol alcohol (iPrOH) acted as a low boiling point solvent and tetralin as high boiling point solvent. iPrOH has a BP of 82.5°C and thus can facilitate uniform drying of the coated wet film. The new titania ink contains (Tetralin: iPrOH (1:1 vol) + TAA (1:10)). The modified ink led to a homogeneous wet film, but even after double coating the dried film was very inhomogeneous (Fig. 3c). While adding a low BP co-solvent did alleviate de-wetting problems of the wet film, the addition of an even faster evaporating alcohol like ethanol (EtOH) was used to improve the homogeneity of the film after drying. With the introduction of a fast evaporating solvent to the ink mixture and optimizing the ratio of the solvents, a further improvement of the homogeneity of the dried film was possible (Fig. 3d). A mixture of the three solvents tetralin: iPrOH: EtOH (TIE) in a 1:1:1 mixture by volume, added with volume fraction of 20:1 to the TAA precursor solution showed good wet as well as dry film formation (Fig. 3e). A line profile through the stripe showed a lower thickness at the edges than at the center due to poor leveling of the thin film. To improve the thin film profile we introduced a fluoro-surfactant to the solvent mixture. Both, wet and dry films were homogeneous with levelled edge profiles as shown in Fig. 3f.

Besides improved pinning, double coating of wet on wet films proved to fill pinholes present in the first layer.

The compositions and printing parameters of the final  $TiO_2$  inks that yielded satisfactory coatings are summarized in Table 1 and Table 2, respectively. After coating, the films were dried at 70°C for 10 min and 200°C for 1 h and then heated to 500 °C on a hot plate (under air) to form a compact  $TiO_2$  film.

Relevant for device fabrication is the final thickness after firing. The thickness has been determined with profilometry from films coated on glass and was found to be 47 nm after double coating.

Fig. 4a shows the critical capillary number describing bead stability during coating as a function of film thickness following Eqn (3). For higher capillary numbers the coating bead became unstable. Due to the low film thickness of cTiO<sub>2</sub>, slot die coating at that speed is close to the critical value, and may not allow increasing the coating speed further. Besides the criteria decisive for ink development, also substrate wettability can be quantified with the help of wetting envelopes.

Fig. 4b shows the wetting envelope of FTO and the surface energies of EtOH, iPrOH, terpineol and tetralin (the solvents utilized during ink development). The surface tensions of the solvents lie well within the wetting envelope for FTO, which at least from a surface energy point of view guarantees proper wetting of the substrate with the ink.

#### Mesoporous TiO<sub>2</sub>

The mTiO<sub>2</sub> layer plays a crucial role in the MPSC, it serves as selective contact for electron extraction and as scaffold for the perovskite crystals. 25 nm were identified as the optimal diameter for the TiO<sub>2</sub> nanoparticles.<sup>37</sup> The screen printing paste Ti-Nanoxide T165/SP used as base ink has a very high viscosity requiring dilution of the paste to adapt it for the slot die coating process. The paste was diluted first with the base solvent terpineol. Similar to cTiO<sub>2</sub>, this led to very slow drying and non-homogeneous film formation. To initiate fast drying as well as to keep the nanoparticle mesoporous ink suspension stable, solvents from the alcohol group only were added. Experiments were performed with iPrOH and EtOH. iPrOH led to very homogeneous wet as well as dry films. Ink composition and properties and processing conditions are summarized in Table 1 and Table 2. The low surface energy of the underlying cTiO<sub>2</sub> makes wetting of the ink a more challenging task, while the coating bead is in the stable region and would allow for a higher coating speed Fig. 4a. The deposited layers were then dried at 110 °C for 10 min and fired at 500°C for 1 h on a hot plate.

#### Mesoporous ZrO<sub>2</sub>

The absence of a hole transport layer makes the introduction of a spacer layer between  $mTiO_2$  and carbon necessary to avoid short cuts in the cell.  $ZrO_2$  is frequently chosen for that purpose for its large band gap and the formation of large pores when processed from nanoparticle inks, that facilitates the infiltration with perovskites. Following the same strategy as for the development of the ink for the  $mTiO_2$  layer, the zirconia ink was developed (Table 1). The ink has a viscosity of 17.5 mPa.s and a surface tension of 25.9 mN/m. The desired thickness of 1000 nm was reached using the ink with two times wet on wet coating with a speed of 0.9 m/min and a flow rate of 1.25 ml/min (Table 2). The wet film was then dried at 110 °C for 10 min at ambient conditions, and fired at 500°C for 1 h on a hot plate.

#### Carbon back electrode

In the MPSC architecture, the carbon layer acts as hole collector as well as electrode. The required 12  $\mu$ m film thickness after firing is still within the range of slot die coating. The screen printing paste was optimized with addition of EtOH and iPrOH to reach good flowability and meniscus formation during slot die coating (Table 1). The ink was deposited with a speed of 0.2 m/min and a flow rate of 0.2 ml/min and dried at 110°C for 10 min. This procedure led to the formation of a homogeneous wet film, and a 10-12  $\mu$ m thick film after firing (Table 2). We believe that due to non-Newtonian behavior of the ink, the meniscus broke sometimes when coated at speeds in excess of 1m/min and

sometimes it led to inhomogeneities in the wet film. The developed carbon ink has a surface tension of 23.4 mN/m as shown in Table 1.

### Cell manufacturing, co-firing and infiltration

After optimizing the slot die coating parameters of individual layers of the device stack, solar cell devices were fabricated on FTO substrates. One set of fully slot die coated samples was prepared, where the completed stack was co-fired at 450°C, skipping the individual firing steps after deposition of each layer. For characterization, smaller cells were cut out of from the substrates (Fig. 2c).

The metal oxide/carbon scaffold was infiltrated with MAPbI<sub>3</sub> with 5-ammonium valeric acid iodide (5-AVAI) additive, which forms mixed-cation perovskite (5-AVAI)x(MA)1-xPbI<sub>3</sub> crystals with lower defect concentration, better pore filling and a more complete contact with the TiO<sub>2</sub> scaffold as compared to single cation MAPbI<sub>3</sub>.<sup>35</sup> The complete cells were incubated by a humidity assisted thermal treatment.<sup>38</sup>

#### Characterization

#### X-ray scattering

To prove the full conversion of the perovskite precursor solution into perovskite, and to exclude decomposition of perovskite into  $Pbl_2$ , XRD measurements were performed on the infiltrated samples. The spectrum is dominated by the diffraction peak of the  $TiO_2$  anatase peak at  $2\Theta = 25.3^\circ$ . A zoom into the spectrum shows all characteristic perovskite peaks, while no peak at the position of  $Pbl_2$  ( $2\Theta = 12.5^\circ$ ) can be identified (Fig. 5).

#### Cell morphology

Cross-sections of the samples were imaged with Scanning Electron Microscopy (SEM), Fig. 6. Noticeable is a strong layering within the carbon layer, with large graphite flakes aligning parallel to the mZrO<sub>2</sub> surface.<sup>39</sup> Important seems a solid infiltration of the carbon layer with perovskite. A zoom into the metal oxide layers shows a very similar grain structure of nanoparticles about 100 nm in diameter for both mTiO<sub>2</sub> and mZrO<sub>2</sub>, whereby the interface between the two materials can be hardly identified. The SEM images speak for a uniform infiltration and crystallization of the mesoporous metal oxide structure, even though differences between non-infiltrated and infiltrated cells are hardly detectable (Fig. S2 in the ESI†). The cTiO<sub>2</sub> is too thin to be resolved in SEM, but a dark line follows the interface between mTiO<sub>2</sub> and FTO. The interface is rather rough, originating from the granular structure of the FTO.<sup>40</sup>

The importance of the morphology of the cTiO<sub>2</sub> hole blocking layer had been pointed out. The cTiO<sub>2</sub> coating must be defect free at lowest thickness to avoid additional series resistance.<sup>41</sup> For that reason an analysis of the FTO surface and the TiO<sub>2</sub> layers applied to FTO by slot die coating was performed by AFM and compared to cTiO<sub>2</sub> films applied by other coating techniques (Table 3, AFM images Fig. 7). The roughness values of the cTiO<sub>2</sub> films applied by spray pyrolysis were closest to the values of the FTO substrate, while slot die coating is most successful in smoothening the FTO surface. Here, a contour-chasing deposition technique would be more favorable, as long as the film is defect-free. XRD proved that independent of the coating technique similar cTiO<sub>2</sub> crystals formed (Fig. S3 in the ESI†).

AFM images of mTiO<sub>2</sub>, mZrO<sub>2</sub> and Carbon surfaces are shown Fig. 8. The mTiO<sub>2</sub> and mZrO<sub>2</sub> surfaces look alike, the similarity of the morphology of the two materials was already observed with SEM. Profiles of the scans show that slot die coating of mTiO<sub>2</sub> and mZrO<sub>2</sub> results in flat and smooth layers. Differently, the slot die coated carbon layer still shows a high surface roughness.

#### Analysis with ellipsometry

Spectrosopic ellipsometry allows obtaining layer parameters from non-destructive measurements on the sample as manufactured under ambient conditions and would be compatible with an in-line assessment of the production quality. The optical parameters of the glass substrate was obtained after removal of the FTO layer and was comparable to a BAK-1 glass. The FTO coating was modelled starting from the structure reported in REF  $^{42}$ . This model includes two thin layers of SnO $_2$  and SiO $_2$  between the glass and the FTO layer. It was noted that the FTO layer had much less absorption in the near infrared compared to the values from the J.A.Woollam database. Adapting the corresponding Drude term by reducing the resistivity to 0.0004  $\Omega$  cm and increasing the scattering time to 7.5 fs led to a better fit and was in agreement with the fact that high conductivity FTO was selected for the PV devices. We further found a hint towards a fluorine reduced top layer which was accommodated by a grading of the FTO layer. The final FTO substrate model consisted of the glass substrate, a 32 nm thick SnO $_2$  layer followed by 25 nm of SiO $_2$  and a total of 370 nm of FTO. Finally, a roughness of around 33 nm, Table 3, could be confirmed.

When depositing a layer of compact  $TiO_2$  on top of the FTO substrate, the roughness turns into an effective medium approximation (EMA) layer made up of the  $cTiO_2$  and the FTO material. As deposited, a  $cTiO_2$  thickness of 175 nm was measured, irrespective of the layer being modeled as a homogeneous oxide or a  $TiO_2$  layer with 40% porosity in the EMA according to Bruggeman, <sup>43</sup> Table 4, Fig. 9.

The printed layer of mTiO<sub>2</sub> on top of the cTiO<sub>2</sub>-FTO stack was added to the ellipsometer model, and a layer thickness of 800 nm with 15nm roughness was fitted. The final layer of ZrO<sub>2</sub> appeared

inhomogeneous and measurements at different locations yielded a thickness variation of 570–800 nm. This thickness variation was most probably caused by the printing process itself.

In the sintered samples the layer structure changed strongly. For the first  $cTiO_2$  layer, a good fit is obtained for a thickness of only 32 nm with 15% void content, while the FTO layer with a fluorine poor grading towards the top is confirmed. When the  $mTiO_2$  layer is added and sintered, a layer thickness of 500 nm with 50% void content is modeled. Finally, the  $ZrO_2$  layer is reasonably well fitted with a mere 175 nm  $ZrO_2$  thickness, again with a high void content of >50%. This value is inconsistent with data from SEM, at the moment we have no satisfying explanation for this.

Rather than sintering the device layer by layer after each printing pass, the entire stack was co-fired. The resulting layer thickness values have a tendency to be larger than the ones from individually sintered layers, and show a slightly higher void content, see Table 5. The ellipsometry layer model is based on a mixture of oxide and void according to the effective medium approximation to explain the lowering of the refractive index. While this model is inspired from a layer with porosity, the change of the refractive index can also be caused by a change in oxide content.

#### **Photovoltaic properties**

Photovoltaic parameters of the reference cell, the development cells and the fully slot die coated cells are shown in Table 6 and Fig. 10. The values are based on reverse scans. Typical J-V curves of a forward and reverse scan of fully slot die coated cells are shown in Fig. 11. We show a device of the first generation with a lower efficiency. The devices showed hysteresis, also reflected in the different fill factors. The reference cell (*fully screen printed*) reached an average efficiency of  $\eta$  = 12.3 %, with  $J_{sc}$  = 23.7 mA cm<sup>-2</sup>,  $V_{oc}$  = 0.92 V and FF = 66 %.

When replacing the screen printed compact  $TiO_2$  layer with a slot die coated  $TiO_2$  layer (1 layer SC), a large drop in efficiency was observed. This is mainly due to reduction of  $J_{sc}$  from  $J_{sc}$  = 23.7 mA cm<sup>-2</sup> to  $J_{sc}$  = 19.1 mA cm<sup>-2</sup>. The explanation is rather straightforward: the slot die coated  $cTiO_2$  layer does not form a conformal thin coating on top of the FTO, but rather fills the valleys, and introduces a serial resistance. A minor drop of  $V_{oc}$  may be due to the slight change in the chemical composition of the slot die coated  $TiO_2$ . <sup>44, 45</sup>

Interestingly, this negative effect was partially compensated when more metal oxide layers were applied by slot die coating (2 layers SC and 3 layers SC).  $V_{oc}$  remained more or less constant, that indicates that the contact potential difference between hole and electron transport materials did not change and the  $ZrO_2$  insulation layer successfully prevented charge recombination. More difficult to explain is the simultaneous increase of  $J_{sc}$  and decrease of fill factor. Assuming a similar geometry of the samples, high reverse saturation current or high ideality can be excluded, as this would also affect  $V_{oc}$ . Higher series resistance or lower shunt resistance would not increase  $J_{sc}$ . For a complete

understanding of the processing happening at the interfaces, a more detailed analysis of processes would be necessary, which is beyond the scope of this paper.

Moving to fully slot die coated devices, the trend from before was reversed: both  $J_{sc}$  and  $V_{oc}$  decreased while the fill factor increased. Here the alignment of graphite flakes parallel to the substrate during slot die coating could be of disadvantage for current extraction. The fully slot die coated and co-fired samples showed the poorest performance, with efficiencies of  $\eta$  = 11.1 %, but also the scatter in data is largest. Reason for the poor performance may be found in the interfaces that get more diffuse during co-firing.

We want to point out that also comparing efficiency values of our cells to current state-of-the art values proved difficult due to the absence of a standard measurement protocol, the strong dependence of measured efficiency on cell area, the detailed measurement routine,  $^{46}$  but also differences in cell manufacturing from laboratory to laboratory. This is also reflected in a large scatter in reported record efficiencies. Parameters of the best performing MPSC cells were reported as  $J_{sc} = 23.40 \text{ mA/cm}^2$ ,  $V_{oc} = 1.08 \text{ V}$ ; FF = 0.72 and power conversion efficiency (PCE) = 17.02 % on small areas (0.129 cm²), whereby cells were manufactured by a combination of spray pyrolysis, screen printing and dipping. Differently, the champion cell reported by Hashmi et al. fabricated by similar means, but infiltration of perovskite by ink jet printing remained below 10%.  $^{12}$ 

To evaluate the robustness of our measurement protocol, we followed different measurement routines for a number of selected cells (Table S1 in the ESI†). It had been suggested to also report the efficiency from maximum power point tracking (mpp, Fig. S4 in the ESI†).<sup>47</sup>

Furthermore, we investigated the long-term device stability of slot die coated devices (Fig. 12). The slot die coated devices showed incredible shelf life stability when stored under ambient conditions. Non-encapsulated devices were stable for one year and only showed signs of degradation after that. The main cause of efficiency loss was the fill factor. The encapsulated devices were stable for more than two years. This indicates the stability of the slot die coated films and interfaces between the different layers of the device stack.

# **Conclusions**

We have demonstrated the development of a truly industrial coating process for the fabrication of perovskite solar cells. All layers of the mesoporous hole transport free carbon-based perovskite solar cell architecture were applied by slot die coating in stripes and on areas up to  $10 \times 10$  cm. Differently from other coating techniques, a process developed for a small area can be directly scaled-up to larger areas, depending on slot width and table length of the instrument. The PCE of the best

performing cells exceeds 12% and is thus in the range of the values reported for cells manufactured by screen printing, which is the standard manufacturing process for this cell architecture. We also suggest spectroscopic ellipsometry as a powerful in-line characterization tool which can deliver similar information as AFM and SEM. Inks for slot die coating are more dilute and contain a smaller volume fraction of binders. That posed serious challenges in the multi-layer printing process in terms of de-wetting during drying, but was rewarded with a coating process that has tremendous advantages over screen printing, starting at the coating speed, but also at the ink composition.

The low binder content proved most advantageous for attempts to co-fire the entire layered stack after printing. This process yielded very poor results with screen printed samples while slot die coated solar cells showed a minor decrease in efficiency, but a major reduction in processing time.

We have also demonstrated an excellent shelf-life stability of fully slot die coated cells exceeding 1 year when stored under ambient conditions.

Next steps to bring this manufacturing process closer to commercialization includes the use of laser ablation for interconnect locations (P1, P2 and P3, see Fig. 2) to achieve higher active areas, the deposition of MAPbI<sub>3</sub> using slot die coating to make use of one coating technique for all layers, and improve the efficiency of film drying for roll-to-roll processing.

# **Experimental Section**

#### **Printing equipment**

Slot die coating was performed on a TSE Troller (Switzerland) table top slot die coater, with a 50 mm wide slot die with integrated shim foils to define a line pattern.

Screen printing was performed on a DEK148 printer with different meshes as specified below.

#### **Materials**

For all inks, screen printing pastes commercially available from Solaronix, SA, Switzerland, were used as base material. For the cTiO<sub>2</sub> layer, the titania precursor ink titanium diisopropoxide bis(acetylacetonate), 75wt% in isopropanal (Sigma Aldrich) was applied, for the mTiO<sub>2</sub> layer, the titania paste Ti-Nanoxide T165/SP (Solaronix, Switzerland) was utilized, for the mZrO<sub>2</sub> layer, the zirconia paste Zr-Nanoxide ZT/SP (Solaronix, Switzerland) was used. The carbon paste Elcocarb B/SPis a mixture of 25 wt% of carbon nanoparticles and graphite flakes (Solaronix, Switzerland).

#### **Device fabrication**

The MPSC solar cell stack consists of a multilayer system of  $cTiO_2$  (50 nm),  $mTiO_2$  (500 nm),  $mZrO_2$  (1000 nm) and Carbon (10-12  $\mu$ m).

Devices were fabricated on 100 mm × 100 mm glass plates coated with laser patterned FTO. The substrates were cleaned by sequential sonication in DI water with pH neutral surfactant, acetone, and isopropanol. After wet cleaning, the substrates were dried with pressurized air and heated to 110 °C for more than 10 min to remove moisture. The FTO glass was also oxygen plasma cleaned to remove any organic residue.

The reference cells were fabricated by semi-automatic screen printing one layer after each other. On the 100 mm  $\times$  100 mm substrate, an array of 18 squares, 10 mm  $\times$  10 mm in size were defined by the stencil (Fig. S5 in the ESI†). Ti-Nanoxide BL150/SP, Ti-Nanoxide T165/SP, Zr-Nanoxide ZT/SP and Elcocarb B/SP were printed using a 150-30, 165-30, 90-48 and 43-80 mesh stencil, respectively. The screen printing inks of mTiO<sub>2</sub> and mZrO<sub>2</sub> are composed of metal oxide nanoparticles with a diameter of 20 nm, and nano-particular carbon about 30 nm in size. The graphite flakes are in the range of several microns.

After printing the wet film, each sample was allowed to dwell for 10 min before drying at 120°C for 10 min, followed by a firing step at 500°C (or 400°C for carbon) for 30 min, after a 30 min ramp.

For the development of suitable inks, we fabricated devices (hereafter called development cells), where the screen printed layers of the reference device were sequentially replaced by slot die coated layers, starting from the bottom, until all layers were slot die coated. The slot die layers consisted of stripes with a width of 15 mm (cTiO<sub>2</sub>, mZrO<sub>2</sub>) or 14 mm (all other layers) defined by a shim foil. The mZrO₂ and carbon layers were printed with an offset to fill the P1 scribe or connect to the FTO layer over the P1 scribe, respectively, as shown Fig. 2a. Similar to the reference cells, the screen printed layers consisted of 18 squares defined by the mesh. The following sample sets were fabricated: cTiO<sub>2</sub> slot die coated, mTiO<sub>2</sub>, mZrO<sub>2</sub> and Carbon screen printed (1 layer SC); cTiO<sub>2</sub> and mTiO<sub>2</sub> slot die coated, mZrO<sub>2</sub> and Carbon screen printed (2 layers SC); cTiO<sub>2</sub>, mTiO<sub>2</sub> and mZrO<sub>2</sub> slot die coated, Carbon screen printed (3 layers SC). After coating the wet film, the screen printed layers were allowed to dwell for 10 min before drying at 120°C for 10 min, followed by a firing step at 500°C (or 400°C for carbon) for 30 min, after a 30 min ramp. The slot die coated layers were dried at 70°C for cTiO₂ and 110°C for the other layers for 10 min, and sintered at 500°C (or 400°C for carbon) for 30 min. The cTiO₂ layer requires an additional drying step where the cTiO₂ coated films were heated to 200°C for 1 h before high temperature sintering. The lateral edges were defined by laser etching in order to form a rectangle similar to the screen printed electrodes. Only when the devices reached an efficiency comparable to the efficiency of the reference cell, the next slot die coated layer was implemented. Ink development work is described in detail in the results and discussion section.

In the *fully slot die coated cells (FULLY SC)*, all layers were deposited by slot die coating and sintered individually.

In *co-fired slot die coated cells (co-fired SC)*, all metal oxide layers were printed and dried, and the fully slot die coated stack was then co-fired at 450°C for 1 hr on a hotplate. Finally the carbon ink was applied and heated to 400°C for 30 min. Coating was performed in a class 6 cleanroom.

#### Infiltration with perovskite

The freshly fired electrodes were masked with an adhesive polyimide gasket (Solaronix) to delimit the wet area. An empirically determined volume of 5.76 µL of perovskite precursor solution was dropped in the center of each electrode using a micropipette. The solution was a methylammonium lead iodide perovskite precursor salt with 5-aminovaleric acid iodide (5-AVAI) additive (Solaronix). The precursor salt was re-dissolved at 70°C right prior to use <sup>48</sup>. The infiltration of MAPbI<sub>3</sub> ink was done using a homemade semi- automated dispensing system. Infiltration is very critical and thus automating the process assures reproducible process, eliminating manual interference. The developed automated robotic dispensing system thus insures controlled drop volume, timing, height of drop release and overall reproducibility. The wet samples were then moved to an oven set to 50°C where they dried for 60 min, hereby forming the perovskite crystals in the porous electrode structure. The polyimide adhesive gasket was carefully peeled off, and the resulting solar cells were submitted to heat and damp treatment at 40°C and 75% r.h. for 150 h.<sup>38</sup> Special precautions were taken to avoid lead contamination, e.g. infiltration was done in a glove box dedicated to work on perovskites.

#### Characterization

Viscosity and density of the inks were measured on a falling ball viscometer from Anton Paar (LOVIS 2000 ME).

Surface tension of the inks was characterized with a drop shape analyzer from Krüss (Fig. S6 in the ESI†).

Surface tension and wetting envelope of the individual layers were determined by following the theory of Owens, Wendt, Rabel and Kaelble<sup>49</sup> and measuring the contact angle of water and diiodomethane on the surface to be investigated. Water has 51 mN/m of polar component and 21.8 mN/m of disperse component adding up to 72.8 mN/m surface tension. Diiodomethane on the other hand is a non-polar solvent with 50.8 mN/m of disperse component.

The *thickness* of the layers was determined with a profilometer (XP-1 Surface Profilometer, Ambios Technology). The *surface topography* was characterized by atomic force microscopy (ICON3 from Bruker) in tapping mode.

SEM images were taken with a FEI NanoSEM 230.

The *crystallization behavior* of the nanoparticles as well as the *perovskite formation* in the mesoporous structure were analyzed by XRD (Pan Analytics, X'Pet pRO).

Slot die printed samples were characterized after addition of each layer before and after sintering using *a spectroscopic ellipsometer* (J.A. Woollam M-2000VI). Areas on the samples were identified by visual inspection where the coating seemed homogeneous. Measurements were performed at three incidence angles of 50°/60°/70°. All samples were prepared with a scotch tape on the backside to prevent backside reflections from reaching the detector.

Solar cell performance of the screen printed cells was measured on cells of 12 mm x 12.5 mm active area, solar cell performance of the slot die coated cells was measured on cells about 12 mm x 12.5 mm in size cut out of stripes. Silver paste was applied on both anode and cathode sides for current collection. The solar cells were fitted with an opaque black adhesive vinyl mask bearing a 0.64 cm<sup>2</sup> aperture (Solaronix), and measured in a SolarSim 150 solar simulator (Solaronix) calibrated to 1000 W/m<sup>2</sup>. The voltage was scanned between -0.3 and 1 V, in 5 mV increments every 1.2 s. For comparison, this slow scanning method was compared to another protocol and to maximum power point tracking as well as to efficiency monitoring at constant voltage (Fig. S4 in the ESI†).

# **Conflicts of Interest**

There are no conflicts to declare.

# **Acknowledgements**

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# **Figures and tables**

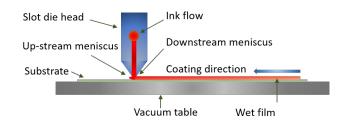
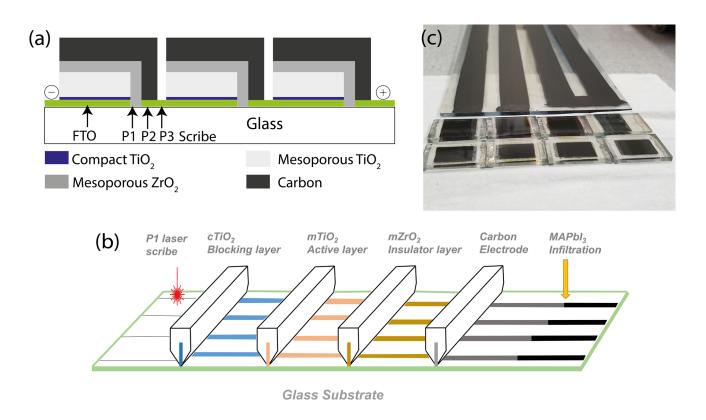
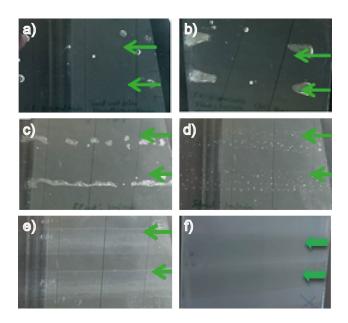


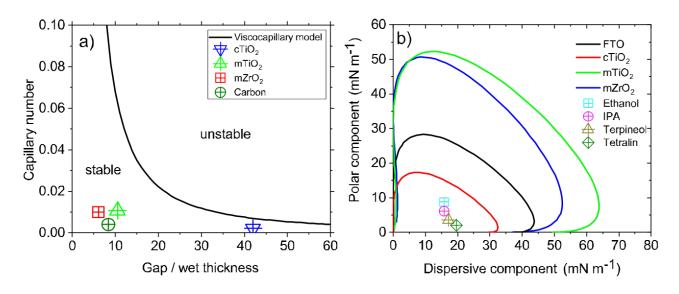
Fig. 1 Schematic representation of the process of slot die coating.



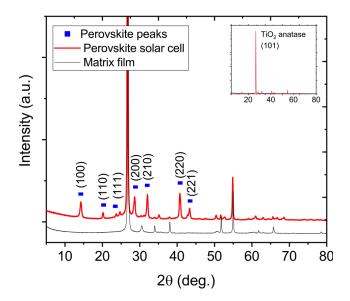
**Fig. 2** (a) Cross-section of a MPSC module, indicating the different layers, as well as the serial connections between adjacent stripes. The connections can be realized by adapting stripe width and offset of the corresponding layers or by laser scribing. (b) Schematics of the processing steps of a fully slot die coated MPSC cell using stripe coating. Compact titania ( $cTiO_2$ ), mesoporous titania ( $mTiO_2$ ), mesoporous zirconia ( $mZrO_2$ ) and carbon layer are sequentially slot die coated. In between the individual coating steps, the samples are dried as specified and only after the mesoporous multilayer film was completed, the entire stack is sintered all together (co-firing). In the last step the solar cell is completed by automatic infiltration of the MAPbl<sub>3</sub> perovskite precursor solution. (c) Making of small area MPSC solar cells for characterization from stripe coated samples: glass pieces  $25 \times 20$  mm in size are cut from the substrates, an active cell area of  $16 \times 12$  mm is then defined by laser scribing.



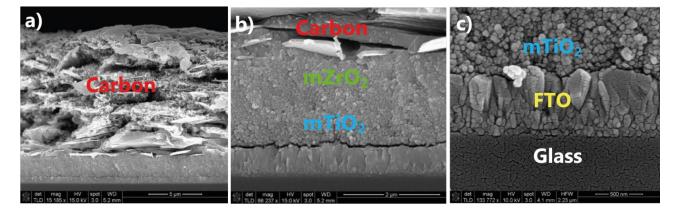
**Fig. 3** Results of slot die coated stripe coatings (green arrows) after drying with the following inks. (a, b) TAA: tetralin 1:10 after single and double coating, respectively, (c) TAA: tetralin: iPrOH 1:5:5, double coating, (d) TAA: tetralin: iPrOH: EtOH 1:10:5:5, annealing at 70 °C, (e) TAA: tetralin: iPrOH: EtOH 3:20:20:20, annealing 70 °C, double coating, (f) TAA: tetralin: iPrOH: EtOH 3:20:20:20:4 surfactant, annealing at 70 °C, double coating.



**Fig. 4** (a) Critical capillary number and capillary numbers of slot die inks as function of gap to wet film thickness ratio. (b) Wettability envelope of the individual layers of a MPSC solar cell and surface energies of solvents used for ink formulation.



**Fig. 5** X-ray diffraction patterns of the MSPC stack after MAPbl<sub>3</sub> infiltration and annealing. The XRD spectrum is dominated by the (101) peak of  $TiO_2$  anatase at  $2\Theta$ =25.3° (inset). A zoom into the peaks of lower intensity shows the characteristic peaks of the cubic phase of the perovskite crystal.<sup>50</sup> No decomposition product of Perovskite into Pbl<sub>2</sub> is present. Pbl<sub>2</sub> would have a characteristic peak at  $2\Theta$  = 12.5°.



**Fig. 6** Cross-sectional SEM images of fully slot die coated MPSCs. (a) Cross-section of the full stack. (b) Zoom into the metal oxide layers. (c) FTO - mTiO<sub>2</sub> interface. The cTiO<sub>2</sub> layer is not visible.

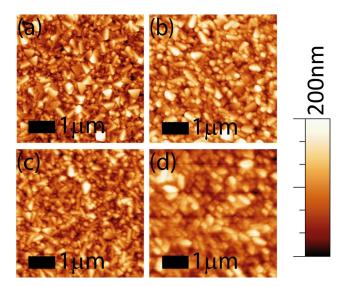


Fig. 7 Topographical images of FTO (a), and cTiO<sub>2</sub> deposited onto FTO by spray pyrolysis (b), screen printing (c) and slot-die coating (d). All samples have been sintered.

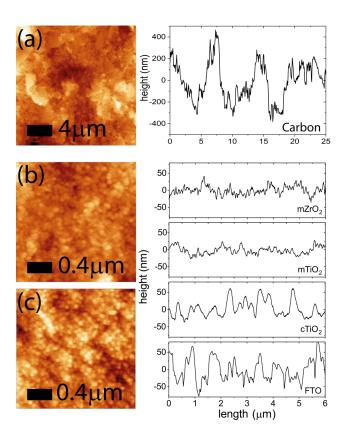
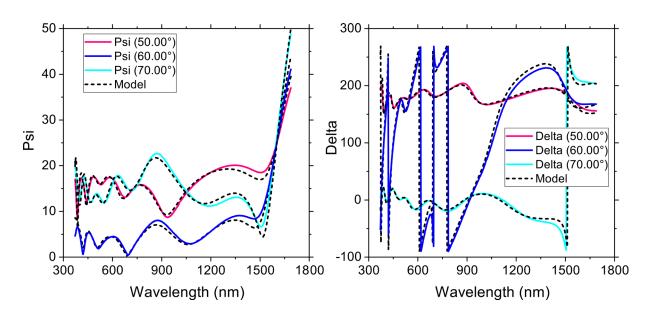
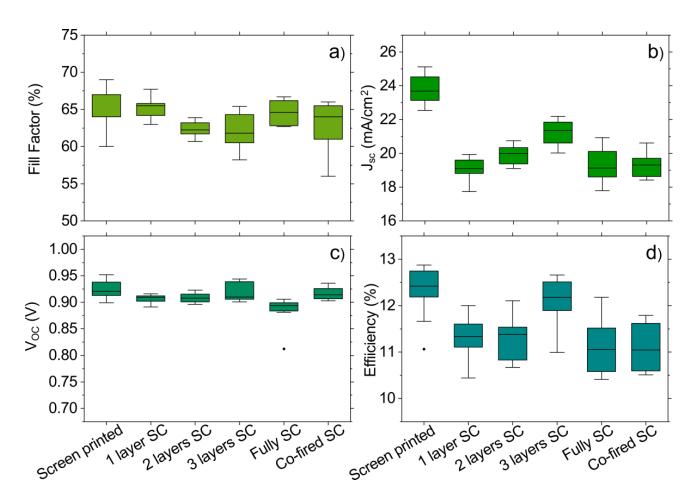


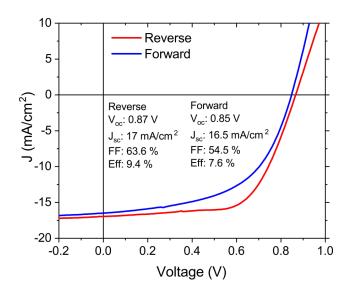
Fig. 8 Left: surface scans of (a) the carbon, (b)  $mZrO_2$  and (c)  $mTiO_2$  layer. Right: surface profiles from the AFM scans.



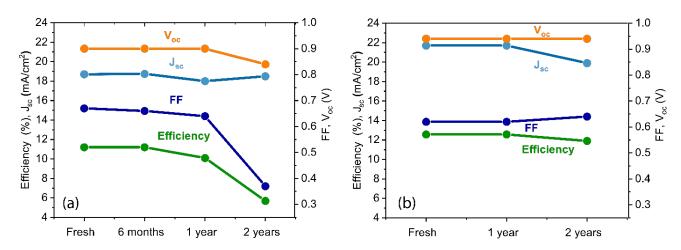
**Fig. 9** Ellipsometric data for the three incidence angles (colored lines) and model fit (dotted lines). Left: Psi, right: Delta.



**Fig. 10** Box plot of the device performance indicators for differently processed cells. (a) Fill factor. (b) Short circuit current  $J_{sc}$ . (c) Open circuit voltage  $V_{oc}$ . (d) Efficiency. The boxes represent the first and third quartiles, the horizontal black line the median, the upper whisker the data within 1.5 times the interquartile range of the upper quartile and the lower whisker 1.5 times the interquartile range of the lower quartile, black dots are the outliers. The data for each configuration are based on a number of independent cells, the number of cells is specified in Table 6.



**Fig. 11** J-V curves with forward and reverse scan of a typical fully slot die coated solar cell measured 23 months after manufacturing (non-encapsulated and stored under ambient conditions). The solar cell is not hysteresis-free.



**Fig. 12** Device performance indicators of (a) fully slot die coated cells without encapsulation (b) three layers slot die coated and encapsulated, after aging in ambient atmosphere at room-temperature.

**Table 1** Compositions and properties of the slot die coating inks developed in this study. The composition numbers relate to volume ratios;  $\rho$  is the density,  $\eta$  the viscosity and  $\gamma$  the surface tension

Ink	Composition	$\rho$ (g/cm <sup>3</sup> )	η (mPa.s)	γ (mN/m)
Compact TiO <sub>2</sub>	TAA:tetralin:iPrOH:EtOH 3:20:20:20 + surfactant	0.85	2.79	22.5
Mesoporous TiO <sub>2</sub>	Titania paste:terpineol:iPrOH 1:7:5	0.89	17.4	27.0
Mesoporous ZrO <sub>2</sub>	Zirconia paste:iPrOH:EtOH 4:5:5	0.88	17.5	25.9
Carbon	Carbon paste:EtOH:iPrOH 2:1:1	0.90	36.8	23.4

**Table 2** Summary of the printing parameters and resulting dry film thicknesses for the slot die coating inks of **Table 1**. The capillary number Ca is calculated from eqn(1)

Ink	Speed	Ca	$h_{gap}/h_{wet}$	Flow rate	Thickness	
	(m/min)			(ml/min)	(nm, double coating)	
Compact TiO <sub>2</sub>	1	0.0021	42	0.2	47	
Mesoporous TiO <sub>2</sub>	1	0.0107	10.5	0.8	550	
Mesoporous ZrO <sub>2</sub>	0.9	0.0101	6.1	1.25	1000	
Carbon	0.2	0.0040	8.4	0.2	10.000-12.000	

**Table 3** Roughness parameters of FTO and the  $cTiO_2$  layers applied by spray pyrolysis, screen printing and slot die coating.  $R_q$  is the root mean squared roughness,  $R_a$  is the arithmetical mean deviation of the assessed profile

	FTO	cTiO₂: Spray Pyrolysis	cTiO₂: Screen print	cTiO₂: Slot die
Image R <sub>q</sub> (nm)	37.8	35.8	31.5	23.3
Image R <sub>a</sub> (nm)	29.6	28.5	25.1	18.5

**Table 4** Parameters of the simulation of the ellipsometer data for the cTiO<sub>2</sub> layer on FTO glass.

Layer	Material	Model	Data	Thickenss (nm)
# 4	TiO₂ and VOID	TaucLor	J.A.Wollam database	176.06
Intermix # 3 / # 4		EMA		43.34
#3	FTO	Oscillator wit Drude term	Data fit	361.40
# 2	SiO <sub>2</sub>	Sellmeier	J.A.Wollam database	25.00
# 1	SnO <sub>2</sub>	General oscillator	J.A.Wollam database	32.00
Substrate	Glass bare	Sellmeier		

**Table 5** Comparison of layer parameters (thickness and void content) for individually sintered and co-fired stacks.

Sintering		cTiO <sub>2</sub>	mTiO <sub>2</sub>	ZrO <sub>2</sub>	Roughness
Thickness (nm)	layer-by-layer	40	510	175	30
	co-fired	60	540	250	25
Void content (%)	layer-by-layer	25	50	55	
	co-fired	35	60	55	

**Table 6** Photovoltaic parameters of MPSCs with screen printed and slot die coated layers. n is the number of measured cells.

	J <sub>sc</sub> (mA/cm <sup>2</sup> )	V <sub>oc</sub> (V)	FF (%)	PCE <sub>avg</sub> (%)	PCE <sub>max</sub> (%)	n
Screen printed (SC), (reference device)	23.7	0.92	66.1	12.3	12.90	10
Slot die coated compact TiO <sub>2</sub> 1 layer SC	19.1	0.91	65.4	11.3	12.01	13
+ Slot die coated mesoporous TiO₂ 2 layers SC	19.9	0.91	62.4	11.3	12.11	8
+ Slot die coated mesoporous ZrO <sub>2</sub> 3 layers SC	21.5	0.92	61.1	12.2	12.66	13
All slot die coated fully SC	19.3	0.88	64.5	11.1	12.20	8
All slot die coated, co- fired Co-fired SC	19.3	0.92	62.9	11.1	11.80	8